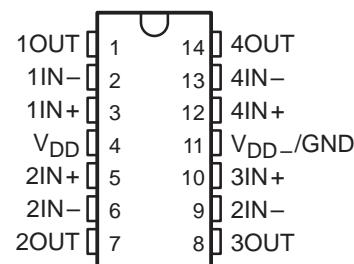


- A-Suffix Versions Offer 5-mV V_{IO}
- B-Suffix Versions Offer 2-mV V_{IO}
- Wide Range of Supply Voltages
1.4 V to 16 V
- True Single-Supply Operation
- Common-Mode Input Voltage Includes the Negative Rail
- Low Noise . . . 25 nV/ $\sqrt{\text{Hz}}$ Typ at $f = 1 \text{ kHz}$
(High-Bias Version)

D, N, OR PW PACKAGE
(TOP VIEW)**description**

The TLC254, TLC254A, TLC254B, TLC25L4, TLC25L4A, TLC25L4B, TLC25M4, TLC25M4A and TLC25M4B are low-cost, low-power quad operational amplifiers designed to operate with single or dual supplies. These devices utilize the Texas Instruments silicon gate LinCMOS™ process, giving them stable input-offset voltages that are available in selected grades of 2, 5, or 10 mV maximum, very high input impedances, and extremely low input offset and bias currents. Because the input common-mode range extends to the negative rail and the power consumption is extremely low, this series is ideally suited for battery-powered or energy-conserving applications. The series offers operation down to a 1.4-V supply, is stable at unity gain, and has excellent noise characteristics.

These devices have internal electrostatic-discharge (ESD) protection circuits that prevent catastrophic failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.1. However, care should be exercised in handling these devices as exposure to ESD may result in degradation of the device parametric performance.

Because of the extremely high input impedance and low input bias and offset currents, applications for these devices include many areas that have previously been limited to BIFET and NFET product types. Any circuit using high-impedance elements and requiring small offset errors is a good candidate for cost-effective use of these devices. Many features associated with bipolar technology are available with LinCMOS operational amplifiers without the power penalties of traditional bipolar devices.

Available options

TA	$V_{IO\max}$ AT 25°C	PACKAGED DEVICES			CHIP FORM (Y)
		SMALL OUTLINE (D)	PLASTIC DIP (N)	TSSOP (PW)	
0°C to 70°C	10 mV	TLC254CD	TLC254CN	TLC254CPW	TLC254Y
	5 mV	TLC254ACD	TLC254ACN	—	—
	2 mV	TLC254BCD	TLC254BCN	—	—
	10 mV	TLC25L4CD	TLC25L4CN	TLC25L4CPW	TLC25L4Y
	5 mV	TLC25L4ACD	TLC25L4ACN	—	—
	2 mV	TLC25L2BCD	TLC25L4BCN	—	—
	10 mV	TLC25M4CD	TLC25M4CN	TLC25M4CPW	TLC25M4Y
	5 mV	TLC25M4ACD	TLC25M4ACN	—	—
	2 mV	TLC25M4BCD	TLC25M4BCN	—	—

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TLC254CDR). Chips are tested at 25°C.

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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description (continued)

General applications such as transducer interfacing, analog calculations, amplifier blocks, active filters, and signal buffering are all easily designed with these devices. Remote and inaccessible equipment applications are possible using their low-voltage and low-power capabilities. These devices are well suited to solve the difficult problems associated with single-battery and solar-cell-powered applications. This series includes devices that are characterized for the commercial temperature range and are available in 14-pin plastic dip and the small-outline packages. The device is also available in chip form.

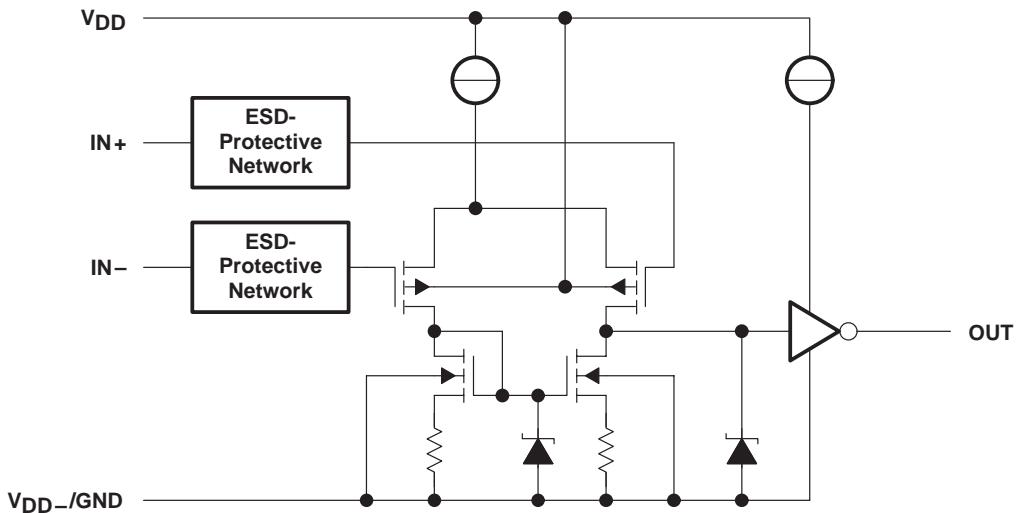
These devices are characterized for operation from 0°C to 70°C.

DEVICE FEATURES

PARAMETER	TLC25L4_C (LOW BIAS)	TLC25M4_C (MEDIUM BIAS)	TLC254_C (HIGH BIAS)
Supply current (Typ)	40 μ A	600 μ A	4000 μ A
Slew rate (Typ)	0.04 V/ μ A	0.6 V/ μ A	4.5 V/ μ A
Input offset voltage (Max)			
TLC254C, TLC25L4C, TLC25M4C	10 mV	10 mV	10 mV
TLC254AC, TLC25L4AC, TLC25M4AC	5 mV	5 mV	5 mV
TLC254BC, TLC25L4BC, TLC25M4BC	2 mV	2 mV	2 mV
Offset voltage drift (Typ)	0.1 μ V/month†	0.1 μ V/month†	0.1 μ V/month†
Offset voltage temperature coefficient (Typ)	0.7 μ V/°C	2 μ V/°C	5 μ V/°C
Input bias current (Typ)	1 pA	1 pA	1 pA
Input offset current (Typ)	1 pA	1 pA	1 pA

† The long-term drift value applies after the first month.

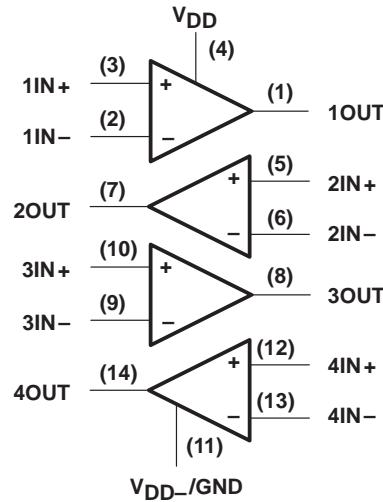
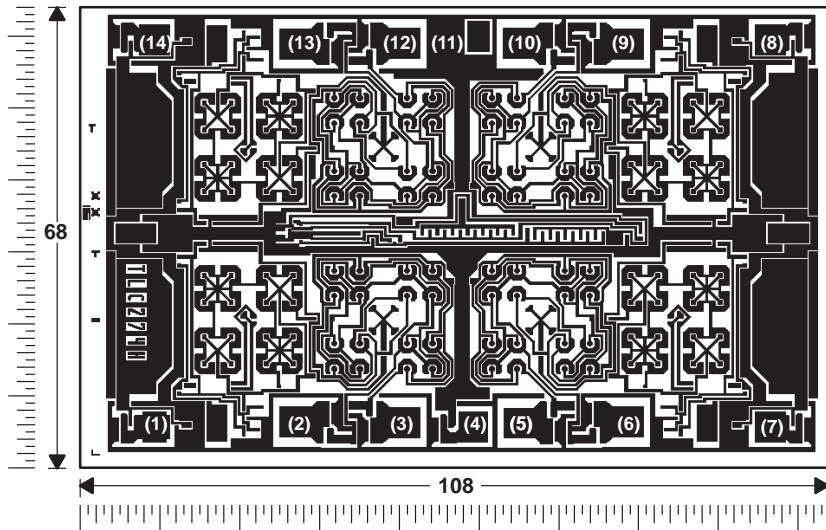
equivalent schematic (each amplifier)



chip information

These chips, when properly assembled, display characteristics similar to the TLC25_4C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS



CHIP THICKNESS: 15 TYPICAL

BONDING PADS: 4 × 4 MINIMUM

T_{Jmax} = 150°C

TOLERANCES ARE ±10%.

ALL DIMENSIONS ARE IN MILS.

PIN (11) IS INTERNALLY CONNECTED
TO BACKSIDE OF CHIP.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{DD} (see Note 1)	18 V
Differential input voltage (see Note 2)	± 18 V
Input voltage range (any input)	-0.3 V to 18 V
Duration of short-circuit at (or below) 25°C free-air temperature (see Note 3)	unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range	0°C to 70°C
Storage temperature range	-65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to V_{DD-}/GND .

2. Differential voltages are at IN+, with respect to IN-.

3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
D	725 mW	5.8 mW/ $^\circ\text{C}$	464 mW
N	1050 mW	9.2 mW/ $^\circ\text{C}$	736 mW
PW	700 mW	5.6 mW/ $^\circ\text{C}$	448 mW

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V_{DD}		1.4	16	V
Common-mode input voltage, V_{IC}	$V_{DD} = 1.4$ V	0	0.2	V
	$V_{DD} = 5$ V	-0.2	4	
	$V_{DD} = 10$ V	-0.2	9	
	$V_{DD} = 16$ V	-0.2	14	
Operating free-air temperature, T_A		0	70	°C

electrical characteristics at specified free-air temperature, $V_{DD} = 1.4$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	TA	TLC254_C			TLC25L4_C			TLC25M4_C			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX		
V _{IO} Input offset voltage	TLC25_4C	V _O = 0.2 V, R _S = 50 Ω	25°C		10			10			10	mV	
			0°C to 70°C		12			12			12		
			25°C		5			5			5		
	TLC25_4AC		0°C to 70°C		6.5			6.5			6.5		
			25°C		2			2			2		
			0°C to 70°C		3			3			3		
a _{VIO} Average temperature coefficient of input offset voltage			25°C to 70°C		1			1			1	µV/°C	
I _{IO} Input offset current		V _O = 0.2 V	25°C		1			1			1	pA	
			0°C to 70°C		300			300			300		
I _{IB} Input bias current		V _O = 0.2 V	25°C		1			1			1	pA	
			0°C to 70°C		600			600			600		
V _{ICR} Common-mode input voltage range			25°C	0 to 0.2		0 to 0.2		0 to 0.2		0 to 0.2		V	
V _{OM} Peak output voltage swing‡	V _{ID} = 100 mV	25°C	450	700		450	700		450	700		mV	
A _{VD} Large-signal differential voltage amplification	V _O = 100 to 300 mV, R _S = 50 Ω	25°C		10			20			20		V/mV	
CMRR Common-mode rejection ratio	V _O = 0.2 V, V _{IC} = V _{ICRmin}	25°C	60	77		60	77		60	77		dB	
I _{DD} Supply current	V _O = 0.2 V, No load	25°C	600	750		50	68		400	500		µA	

† All characteristics are measured under open-loop conditions with zero common-mode input voltage unless otherwise specified. Unless otherwise noted, an output load resistor is connected from the output to ground and has the following value: for low bias, R_L = 1 MΩ, for medium bias R_L = 100 kΩ, and for high bias R_L = 10 kΩ.

‡ The output swings to the potential of V_{DD}-/GND.

operating characteristics, $V_{DD} = 1.4$ V, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC254_C			TLC25L4_C			TLC25M4_C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	See Figure 1		0.1			0.001			0.01		V/µs
B ₁ Unity-gain bandwidth	A _V = 40 dB, C _L = 10 pF, R _S = 50 Ω, See Figure 1		12			12			12		kHz
Overshoot factor	See Figure 1		30%			35%			35%		

electrical characteristics at specified free-air temperature, $V_{DD} = 5$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC254, TLC254AC, TLC254BC			UNIT	
				MIN	TYP	MAX		
V_{IO}	Input offset voltage	TLC254C	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 10 \text{ k}\Omega$	25°C	1.1	10	mV
		TLC254AC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 10 \text{ k}\Omega$	25°C	0.9	5	
		TLC254BC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 10 \text{ k}\Omega$	25°C	0.34	2	
α_{VIO}	Average temperature coefficient of input offset voltage			25°C to 70°C		1.8	$\mu\text{V}/^\circ\text{C}$	
				25°C		0.1		
I_{IO}	Input offset current (see Note 4)		$V_O = 2.5$ V,	$V_{IC} = 2.5$ V	70°C	7	300	pA
					25°C	0.6		
I_{IB}	Input bias current (see Note 4)		$V_O = 2.5$ V,	$V_{IC} = 2.5$ V	70°C	40	600	pA
					25°C	-0.2 to 4	-0.3 to 4.2	
V_{ICR}	Common-mode input voltage range (see Note 5)				Full range	-0.2 to 3.5		V
					25°C			
V_{OH}	High-level output voltage		$V_{ID} = 100 \text{ mV},$ $R_L = 10 \text{ k}\Omega$	0°C	3	3.8	V	
				25°C	3.2	3.8		
				70°C	3	3.8		
V_{OL}	Low-level output voltage		$V_{ID} = -100 \text{ mV},$ $I_{OL} = 0$	0°C	0	50	mV	
				25°C	0	50		
				70°C	0	50		
A_{VD}	Large-signal differential voltage amplification		$V_O = 0.25 \text{ V to } 2 \text{ V},$ $R_L = 10 \text{ k}\Omega$	0°C	4	27	V/mV	
				25°C	5	23		
				70°C	4	20		
$CMRR$	Common-mode rejection ratio		$V_{IC} = V_{ICR\min}$	0°C	60	84	dB	
				25°C	65	80		
				70°C	60	85		
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5 \text{ V to } 10 \text{ V},$ $V_O = 1.4 \text{ V}$	0°C	60	94	dB	
				25°C	65	95		
				70°C	60	96		
I_{DD}	Supply current (four amplifiers)		$V_O = 2.5 \text{ V},$ No load	0°C	3.1	7.2	mA	
				25°C	2.7	6.4		
				70°C	2.3	5.2		

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.



electrical characteristics at specified free-air temperature, $V_{DD} = 10$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC254C, TLC254AC, TLC254BC			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	1.1	10	12	mV
			Full range				
		$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	0.9	5	6.5	
	TLC254BC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	0.39	2	3	
			Full range				
ΔV_{IO}	Average temperature coefficient of input offset voltage		25°C to 70°C	2			$\mu\text{V}/^\circ\text{C}$
I_{IO}	Input offset current (see Note 4)		25°C	0.1			pA
			70°C	7	300		
I_{IB}	Input bias current (see Note 4)		25°C	0.7			pA
			70°C	50	600		
V_{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2	-0.3	to 9	V
			Full range	-0.2	to 8.5	9.2	
V_{OH}	High-level output voltage		0°C	7.8	8.5		V
			25°C	8	8.5		
			70°C	7.8	8.4		
V_{OL}	Low-level output voltage		0°C	0	50		mV
			25°C	0	50		
			70°C	0	50		
AVD	Large-signal differential voltage amplification		0°C	7.5	42		V/mV
			25°C	10	36		
			70°C	7.5	32		
$CMRR$	Common-mode rejection ratio		0°C	60	88		dB
			25°C	65	85		
			70°C	60	88		
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		0°C	60	94		dB
			25°C	65	95		
			70°C	60	96		
I_{DD}	Supply current (four amplifiers)		0°C	4.5	8.8		mA
			25°C	3.8	8		
			70°C	3.2	6.8		

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	TA	TLC254C, TLC254AC, TLC254BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 10\text{ k}\Omega$, See Figure 1	$C_L = 20\text{ pF}$,	0°C	4		V/ μs
			25°C	3.6		
			70°C	3		
			0°C	3.1		
			25°C	2.9		
			70°C	2.5		
V_n	Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\text{ }\Omega$, See Figure 2	25°C	25		nV/ $\sqrt{\text{Hz}}$
BOM Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20\text{ pF}$, $R_L = 10\text{ k}\Omega$,	0°C	340		kHz
			25°C	320		
			70°C	260		
B1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	0°C	2		MHz
			25°C	1.7		
			70°C	1.3		
ϕ_m Phase margin	$V_I = 10\text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20\text{ pF}$,	0°C	47°		
			25°C	46°		
			70°C	43°		

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS	TA	TLC254C, TLC254AC, TLC254BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 10\text{ k}\Omega$, See Figure 1	$C_L = 20\text{ pF}$,	0°C	5.9		V/ μs
			25°C	5.3		
			70°C	4.3		
			0°C	5.1		
			25°C	4.6		
			70°C	3.8		
V_n	Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\text{ }\Omega$, See Figure 2	25°C	25		nV/ $\sqrt{\text{Hz}}$
BOM Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20\text{ pF}$, $R_L = 10\text{ k}\Omega$,	0°C	220		kHz
			25°C	200		
			70°C	140		
B1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	0°C	2.5		MHz
			25°C	2.2		
			70°C	1.8		
ϕ_m Phase margin	$V_I = 10\text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20\text{ pF}$,	0°C	50°		
			25°C	49°		
			70°C	46°		

electrical characteristics at specified free-air temperature, $V_{DD} = 5$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC25L4C TLC25L4AC TLC25L4BC			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	1.1	10		mV
			Full range		12		
		$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	0.9	5		
	TLC25L4BC	$R_L = 1 M\Omega$	Full range		6.5		
		$V_O = 1.4$ V, $R_S = 50 \Omega$,	25°C	0.24	2		
			Full range		3		
$\approx V_{IO}$	Average temperature coefficient of input offset voltage		25°C to 70°C	1.1			$\mu V/^\circ C$
I_{IO}	Input offset current (see Note 4)	$V_O = 2.5$ V,	25°C	0.1			pA
			70°C	7	300		
I_{IB}	Input bias current (see Note 4)	$V_O = 2.5$ V,	25°C	0.6			pA
			70°C	40	600		
V_{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2	-0.3		V
			to 4	to 4	4.2		
			Full range	-0.2			
				to 3.5			
V_{OH}	High-level output voltage	$V_{ID} = 100$ mV, $R_L = 1 M\Omega$	0°C	3	4.1		V
			25°C	3.2	4.1		
			70°C	3	4.2		
V_{OL}	Low-level output voltage	$V_{ID} = -100$ mV, $I_{OL} = 0$	0°C	0	50		mV
			25°C	0	50		
			70°C	0	50		
A_{VD}	Large-signal differential voltage amplification	$V_O = 0.25$ V to 2 V, $R_L = 1 M\Omega$	0°C	50	680		V/mV
			25°C	50	520		
			70°C	50	380		
CMRR	Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$	0°C	60	95		dB
			25°C	65	94		
			70°C	60	95		
k _{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 5$ V to 10 V, $V_O = 1.4$ V	0°C	60	97		dB
			25°C	70	98		
			70°C	60	97		
I_{DD}	Supply current (four amplifiers)	$V_O = 2.5$ V, $V_{IC} = 2.5$ V, No load	0°C	48	84		μA
			25°C	40	68		
			70°C	31	56		

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.

electrical characteristics at specified free-air temperature, $V_{DD} = 10$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC25L4C TLC25L4AC TLC25L4BC			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLC25L4C $V_O = 1.4$ V, $R_S = 50 \Omega$, $R_L = 1 M\Omega$	25°C	1.1	10		mV
			Full range		12		
		TLC25L4AC $V_O = 1.4$ V, $R_S = 50 \Omega$, $R_L = 1 M\Omega$	25°C	0.9	5		
		TLC25L4BC $V_O = 1.4$ V, $R_S = 50 \Omega$, $R_L = 1 M\Omega$	25°C	0.26	2		
			Full range		3		
αV_{IO}	Average temperature coefficient of input offset voltage		25°C to 70°C	1			$\mu V/^\circ C$
I_{IO}	Input offset current (see Note 4)	$V_O = 5$ V, $V_{IC} = 5$ V	25°C	0.1			pA
			70°C	7	300		
I_{IB}	Input bias current (see Note 4)	$V_O = 5$ V, $V_{IC} = .5$ V	25°C	0.7			pA
			70°C	50	600		
V_{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2	-0.3		V
				to 9	to 9.2		
			Full range	-0.2			
				to 8.5			
V_{OH}	High-level output voltage	$V_{ID} = 100$ mV, $R_L = 1 M\Omega$	0°C	7.8	8.9		V
			25°C	8	8.9		
			70°C	7.8	8.9		
V_{OL}	Low-level output voltage	$V_{ID} = -100$ mV, $I_{OL} = 0$	0°C	0	50		mV
			25°C	0	50		
			70°C	0	50		
AVD	Large-signal differential voltage amplification	$V_O = 1$ V to 6 V, $R_L = 1 M\Omega$	0°C	50	1025		V/mV
			25°C	50	870		
			70°C	50	660		
$CMRR$	Common-mode rejection ratio	$V_{IC} = V_{ICR\min}$	0°C	60	97		dB
			25°C	65	97		
			70°C	60	97		
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 5$ V to 10 V, $V_O = 1.4$ V	0°C	60	97		dB
			25°C	70	97		
			70°C	60	98		
I_{DD}	Supply current (four amplifiers)	$V_O = 5$ V, $V_{IC} = 5$ V, No load	0°C	72	132		μA
			25°C	57	92		
			70°C	44	80		

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.

operating characteristics, $V_{DD} = 5$ V

PARAMETER	TEST CONDITIONS	T_A	TLC25L4C TLC25L4AC TLC25L4BC			UNIT
			MIN	TYP	MAX	



SR	Slew rate at unity gain	$R_L = 1 \text{ M}\Omega$, See Figure 1	$C_L = 20 \text{ pF}$	$V_I(\text{PP}) = 1 \text{ V}$	0°C	0.04	V/ μs
				$V_I(\text{PP}) = 2.5 \text{ V}$	25°C	0.03	
					70°C	0.03	
					0°C	0.03	
			$C_L = 20 \text{ pF}, R_L = 1 \text{ M}\Omega$, See Figure 1	$V_I(\text{PP}) = 2.5 \text{ V}$	25°C	0.03	
					70°C	0.02	
					25°C	70	nV/ $\sqrt{\text{Hz}}$
					0°C	6	kHz
B _{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20 \text{ pF}, R_L = 1 \text{ M}\Omega$, See Figure 1	$V_I(\text{PP}) = 1 \text{ V}$	25°C	5	
					70°C	4.5	
					0°C	100	kHz
B ₁	Unity-gain bandwidth	$V_I = 10 \text{ mV}$, See Figure 1	$C_L = 20 \text{ pF}$, See Figure 1	$V_I(\text{PP}) = 1 \text{ V}$	25°C	85	
					70°C	65	
					0°C	36°	
ϕ_m	Phase margin	$V_I = 10 \text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20 \text{ pF}$	$V_I(\text{PP}) = 1 \text{ V}$	25°C	34°	
					70°C	30°	
					0°C	30°	

operating characteristics, $V_{DD} = 10 \text{ V}$

PARAMETER	TEST CONDITIONS	TA	TLC25L4C TLC25L4AC TLC25L4BC			UNIT	
			MIN	TYP	MAX		
SR	$R_L = 1 \text{ M}\Omega$, See Figure 1	$C_L = 20 \text{ pF}$	$V_I(\text{PP}) = 1 \text{ V}$	0°C	0.05	V/ μs	
				25°C	0.05		
				70°C	0.04		
			$V_I(\text{PP}) = 5.5 \text{ V}$	0°C	0.05		
		$C_L = 20 \text{ pF}, R_L = 1 \text{ M}\Omega$, See Figure 1		25°C	0.04		
				70°C	0.04		
				0°C	1.3	kHz	
				25°C	1		
B _{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20 \text{ pF}$, $R_L = 1 \text{ M}\Omega$, See Figure 1	$V_I(\text{PP}) = 1 \text{ V}$	70°C	0.9	
					0°C	125	kHz
					25°C	110	
B ₁	Unity-gain bandwidth	$V_I = 10 \text{ mV}$, See Figure 1	$C_L = 20 \text{ pF}$, See Figure 1	$V_I(\text{PP}) = 1 \text{ V}$	70°C	90	
					0°C	40°	
					25°C	38°	
ϕ_m	Phase margin	$V_I = 10 \text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20 \text{ pF}$	$V_I(\text{PP}) = 1 \text{ V}$	70°C	34°	

electrical characteristics at specified free-air temperature, $V_{DD} = 5$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC25M4C TLC25M4AC TLC25M4BC			UNIT	
				MIN	TYP	MAX		
V_{IO}	Input offset voltage	TLC25M4C	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	1.1	10	mV
		TLC25M4AC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	0.9	5	
		TLC25M4BC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	0.25	2	
					Full range		3	
	$\approx V_{IO}$	Average temperature coefficient of input offset voltage			25°C to 70°C	1.7		
					25°C	0.1		
I_{IO}	Input offset current (see Note 4)		$V_O = 2.5$ V,	$V_{IC} = 2.5$ V	70°C	7	300	pA
	I_{IB}	Input bias current (see Note 4)		$V_O = 2.5$ V,	$V_{IC} = 2.5$ V	25°C	0.6	
						70°C	40 600	pA
					25°C	-0.2 t0 to 4	-0.3 4.2	V
V_{ICR}	Common-mode input voltage range (see Note 5)				Full range	-0.2 to 3.5		V
					0°C	3	3.9	V
					25°C	3.2	3.9	
					70°C	3	4	
V_{OL}	Low-level output voltage		$V_{ID} = -100$ mV,	$R_L = 100 \text{ k}\Omega$	0°C	0	50	mV
					25°C	0	50	
					70°C	0	50	
					0°C	15	200	V/mV
A_{VD}	Large-signal differential voltage amplification		$V_O = 0.25$ V to 2 V,	$R_L = 100 \text{ k}\Omega$	25°C	25	170	
					70°C	15	140	
					0°C	60	91	dB
$CMRR$	Common-mode rejection ratio		$V_{IC} = V_{ICR\min}$		25°C	65	91	
					70°C	60	92	
					0°C	60	92	dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5$ V to 10 V,	$V_O = 1.4$ V	25°C	70	93	
					70°C	60	94	
					0°C	500	1280	μ A
I_{DD}	Supply current (four amplifiers)		$V_O = 2.5$ V, No load	$V_{IC} = 2.5$ V,	25°C	420	1120	
					70°C	340	880	

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.

electrical characteristics at specified free-air temperature, $V_{DD} = 10$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	TLC25M4C TLC25M4AC TLC25M4BC			UNIT				
				MIN	TYP	MAX					
V_{IO}	Input offset voltage	TLC25M4C	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	1.1	10	mV			
		TLC25M4AC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	0.9	5				
		TLC25M4BC	$V_O = 1.4$ V, $R_S = 50 \Omega$,	$V_{IC} = 0$, $R_L = 100 \text{ k}\Omega$	25°C	0.26	2				
	Average temperature coefficient of input offset voltage				Full range		3				
						25°C to 70°C	2.1				
						70°C					
I_{IO}	Input offset current (see Note 4)		$V_O = 5$ V,	$V_{IC} = 5$ V	25°C	0.1		pA			
					70°C	7	300				
	Input bias current (see Note 4)		$V_O = 5$ V,	$V_{IC} = 5$ V	25°C	0.7					
					70°C	50	600				
V_{ICR}	Common-mode input voltage range (see Note 5)				25°C	-0.2 to 9	-0.3 to 9.2	V			
					Full range	-0.2 to 8.5		V			
	High-level output voltage		$V_{ID} = 100 \text{ mV}$,	$R_L = 100 \text{ k}\Omega$	0°C	7.8	8.7	V			
					25°C	8	8.7				
					70°C	7.8	8.7				
V_{OL}	Low-level output voltage		$V_{ID} = -100 \text{ mV}$,	$I_{OL} = 0$	0°C	0	50	mV			
					25°C	0	50				
					70°C	0	50				
AVD	Large-signal differential voltage amplification		$V_O = 1$ V to 6 V,	$R_L = 100 \text{ k}\Omega$	0°C	15	320	V/mV			
					25°C	25	275				
					70°C	15	230				
	Common-mode rejection ratio		$V_{IC} = V_{ICR\min}$		0°C	60	94				
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)				25°C	65	94				
					70°C	60	94				
					0°C	60	92				
					25°C	70	93				
I_{DD}	Supply current (four amplifiers)		$V_O = 5$ V, No load	$V_{IC} = 5$ V,	0°C	690	1600	μA			
					25°C	570	1200				
					70°C	440	1120				

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.

operating characteristics, $V_{DD} = 5$ V

PARAMETER	TEST CONDITIONS	T_A	TLC25M4C TLC25M4AC TLC25M4BC			UNIT
			MIN	TYP	MAX	



SR	Slew rate at unity gain	$R_L = 100 \text{ k}\Omega$, $C_L = 20 \text{ pF}$, See Figure 1	$V_I(\text{PP}) = 1 \text{ V}$	0°C	0.46	$\text{V}/\mu\text{s}$
				25°C	0.43	$\text{V}/\mu\text{s}$
				70°C	0.36	$\text{V}/\mu\text{s}$
			$V_I(\text{PP}) = 2.5 \text{ V}$	0°C	0.43	
				25°C	0.40	
				70°C	0.34	
V_n	Equivalent input noise voltage	$f = 1 \text{ kHz}$, $R_S = 20 \Omega$, See Figure 2		25°C	32	$\text{nV}/\sqrt{\text{Hz}}$
B _{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20 \text{ pF}$, $R_L = 100 \text{ k}\Omega$,	0°C	60	kHz
				25°C	55	
				70°C	50	
B ₁	Unity-gain bandwidth	$V_I = 10 \text{ mV}$, See Figure 1	$C_L = 20 \text{ pF}$, See Figure 1	0°C	610	kHz
				25°C	525	
				70°C	400	
ϕ_m	Phase margin	$V_I = 10 \text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20 \text{ pF}$,	0°C	41°	
				25°C	40°	
				70°C	39°	

operating characteristics, $V_{DD} = 10 \text{ V}$

PARAMETER	TEST CONDITIONS	TA	TLC25M4C TLC25M4AC TLC25M4BC			UNIT
			MIN	TYP	MAX	
SR	$R_L = 100 \text{ k}\Omega$, See Figure 1	$C_L = 20 \text{ pF}$, $V_I(\text{PP}) = 1 \text{ V}$	0°C	0.67		$\text{V}/\mu\text{s}$
			25°C	0.62		
			70°C	0.51		
		$V_I(\text{PP}) = 5.5 \text{ V}$	0°C	0.61		
			25°C	0.56		
			70°C	0.46		
V_n	Equivalent input noise voltage	$f = 1 \text{ kHz}$, $R_S = 20 \Omega$, See Figure 2	25°C	32		$\text{nV}/\sqrt{\text{Hz}}$
B _{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$, See Figure 1	$C_L = 20 \text{ pF}$, $R_L = 100 \text{ k}\Omega$,	0°C	40	kHz
				25°C	35	
				70°C	30	
B ₁	Unity-gain bandwidth	$V_I = 10 \text{ mV}$, See Figure 1	$C_L = 20 \text{ pF}$, See Figure 1	0°C	710	kHz
				25°C	635	
				70°C	510	
ϕ_m	Phase margin	$V_I = 10 \text{ mV}$, See Figure 3	$f = B_1$, $C_L = 20 \text{ pF}$,	0°C	44°	
				25°C	43°	
				70°C	42°	



electrical characteristics, $V_{DD} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLC254Y			TLC25L4Y			TLC25M4Y			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage See Note 6	$V_O = 1.4 \text{ V}$, $V_{IC} = 0 \text{ V}$, $R_S = 50 \Omega$	1.1	10	1.1	10	1.1	10	1.1	10	mV
αV_{IO}	Average temperature coefficient of input offset voltage		1.8		1.1		1.7				$\mu\text{V}/^\circ\text{C}$
I_{IO}	Input offset current (see Note 4)	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$	0.1		0.1		0.1				pA
I_{IB}	Input bias current (see Note 4)	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$	0.6		0.6		0.6				pA
V_{ICR}	Common-mode input voltage range (see Note 5)		-0.2 to 4	-0.3 to 4.2	-0.2 to 4	-0.3 to 4.2	-0.2 to 4	-0.3 to 4.2	-0.2 to 4	-0.3 to 4.2	V
V_{OH}	High-level output voltage	$V_{ID} = 100 \text{ mV}$, $R_L = 100 \text{ k}\Omega$	3.2	3.8	3.2	4.1	3.2	3.9	3.2	3.9	V
V_{OL}	Low-level output voltage	$V_{ID} = -100 \text{ mV}$, $I_{OL} = 0$	0	50	0	50	0	50	0	50	mV
AV_D	Large-signal differential voltage amplification	$V_O = 0.25 \text{ V}$, See Note 6	5	23	50	520	25	170			V/mV
CMRR	Common-mode rejection ratio	$V_{IC} = V_{ICR\min}$	65	80	65	94	65	91			dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 5 \text{ V to } 10 \text{ V}$, $V_O = 1.4 \text{ V}$	65	95	70	97	70	93			dB
I_{DD}	Supply current	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$, No load	2.7	6.4	0.04	0.068	0.42	1.12			mA

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

6. For low-bias mode, $R_L = 1 \text{ M}\Omega$, for medium-bias mode, $R_L = 100 \text{ k}\Omega$, and for high-bias mode, $R_L = 10 \text{ k}\Omega$.**operating characteristics, $V_{DD} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$**

PARAMETER	TEST CONDITIONS	TLC254Y			TLC25L4Y			TLC25M4Y			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	$C_L = 20 \text{ pF}$, See Note 6	$V_I(\text{PP}) = 1 \text{ V}$	3.6		0.03		0.43				$\text{V}/\mu\text{s}$
		$V_I(\text{PP}) = 2.5 \text{ V}$	2.9		0.03		0.40				
V_n	Equivalent input noise voltage	$f = 1 \text{ kHz}$, $R_S = 20 \Omega$	2.5		70		32				$\text{nV}/\sqrt{\text{Hz}}$
B_{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$, $R_L = 10 \text{ k}\Omega$	320		5		55				kHz
B_1	Unity-gain bandwidth	$V_I = 10 \text{ mV}$, $C_L = 20 \text{ pF}$	1.7		0.085		0.525				MHz
ϕ_m	Phase margin	$f = B_1$, $C_L = 20 \text{ pF}$	46°		34°		40°				

NOTE 6: For low-bias mode, $R_L = 1 \text{ M}\Omega$, for medium-bias mode, $R_L = 100 \text{ k}\Omega$, and for high-bias mode, $R_L = 10 \text{ k}\Omega$.

PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

Because the TLC25_4, TLC25_4A, and TLC25_4B are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

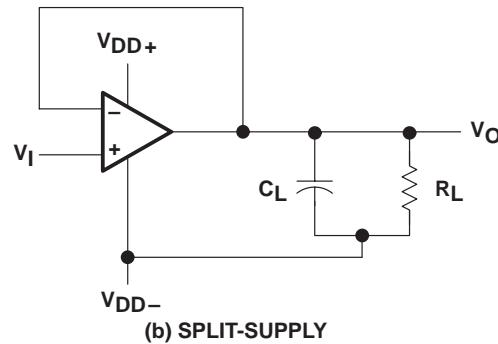
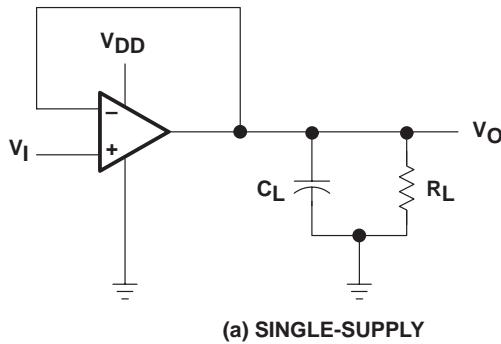


Figure 1. Unity-Gain Amplifier

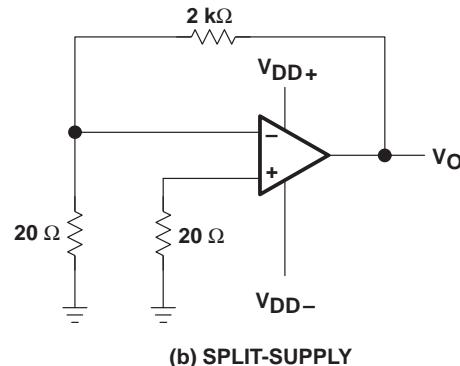
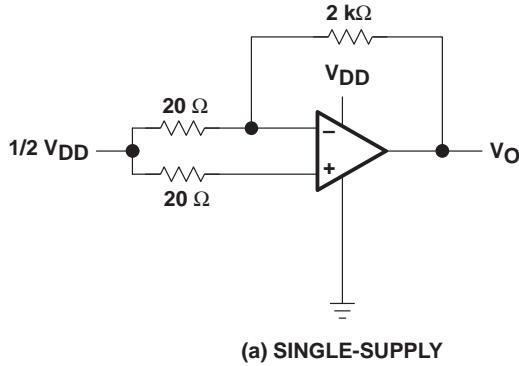


Figure 2. Noise-Test Circuit

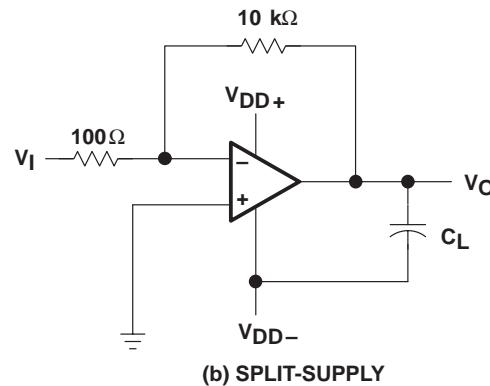
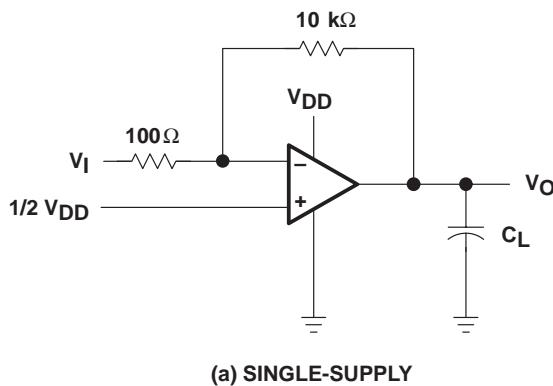


Figure 3. Gain-of-100 Inverting Amplifier

TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
I_{DD}	Supply current	vs Supply voltage vs Free-air temperature	4 5
A_{VD}	Large-signal differential voltage amplification	Low bias vs Frequency	6
		Medium bias vs Frequency	7
		High bias vs Frequency	8
Phase shift	Phase shift	Low bias vs Frequency	6
		Medium bias vs Frequency	7
		High bias vs Frequency	8

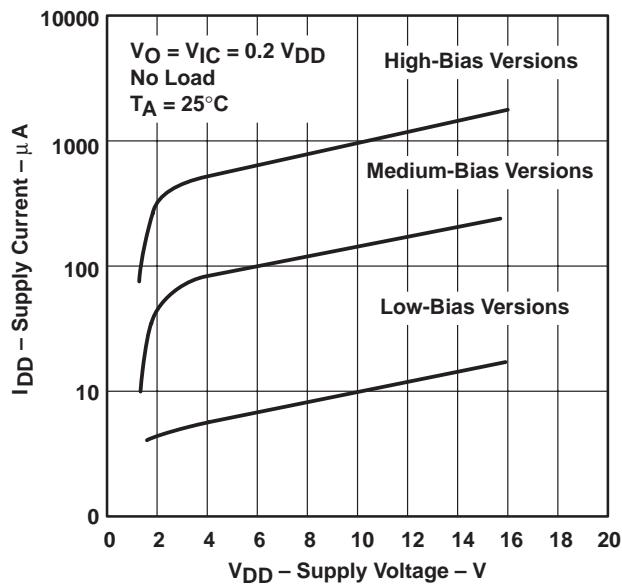
SUPPLY CURRENT
VS
SUPPLY VOLTAGE

Figure 4

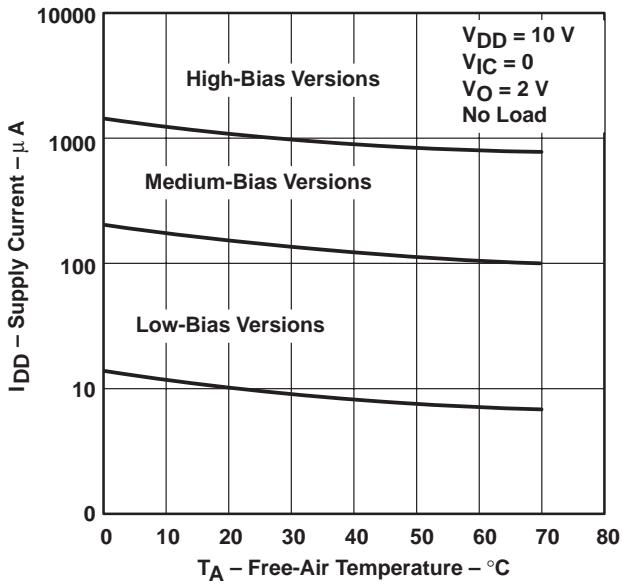
SUPPLY CURRENT
VS
FREE-AIR TEMPERATURE

Figure 5

TYPICAL CHARACTERISTICS

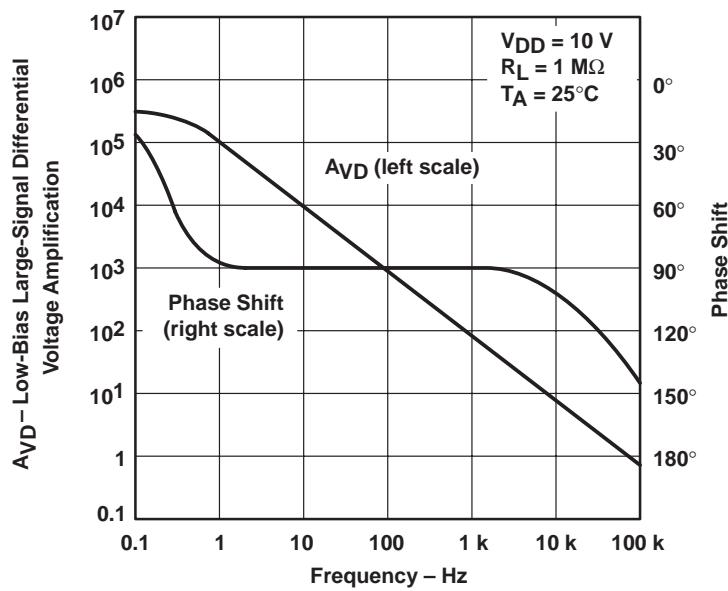
LOW-BIAS LARGE-SIGNAL DIFFERENTIAL
VOLTAGE AMPLIFICATION AND PHASE SHIFT
vs
FREQUENCY

Figure 6

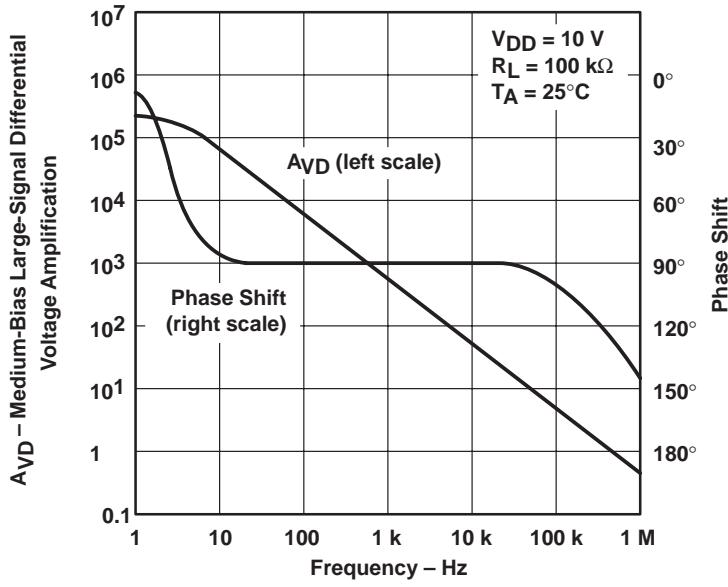
MEDIUM-BIAS LARGE-SIGNAL
DIFFERENTIAL VOLTAGE AMPLIFICATION
AND PHASE SHIFT
vs
FREQUENCY

Figure 7

TYPICAL CHARACTERISTICS

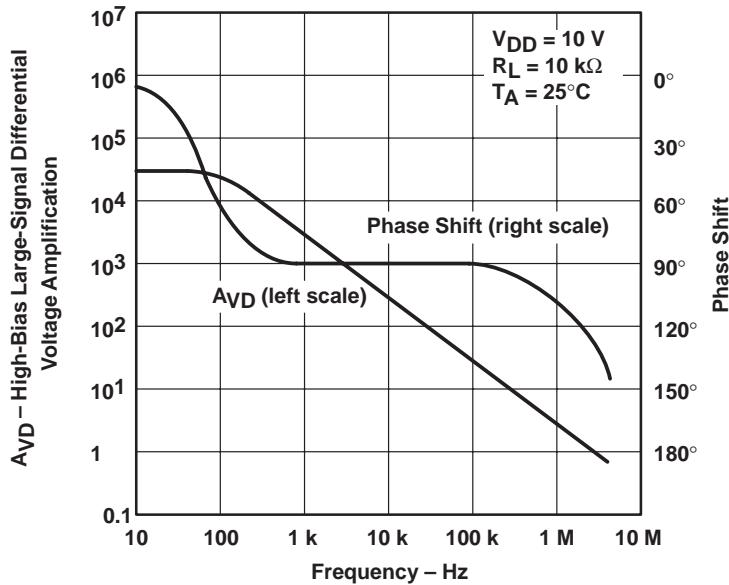
HIGH-BIAS LARGE-SIGNAL
DIFFERENTIAL VOLTAGE AMPLIFICATION
AND PHASE SHIFT
VS
FREQUENCY

Figure 8

APPLICATION INFORMATION

latch-up avoidance

Junction-isolated CMOS circuits have an inherent parasitic PNPN structure that can function as an SCR. Under certain conditions, this SCR may be triggered into a low-impedance state, resulting in excessive supply current. To avoid such conditions, no voltage greater than 0.3 V beyond the supply rails should be applied to any pin. In general, the operational amplifiers supplies should be established simultaneously with, or before, application of any input signals.

output stage considerations

The amplifier's output stage consists of a source-follower-connected pullup transistor and an open-drain pulldown transistor. The high-level output voltage (V_{OH}) is virtually independent of the I_{DD} selection and increases with higher values of V_{DD} and reduced output loading. The low-level output voltage (V_{OL}) decreases with reduced output current and higher input common-mode voltage. With no load, V_{OL} is essentially equal to the potential of V_{DD-}/GND .

supply configurations

Even though the TLC25_4C series is characterized for single-supply operation, they can be used effectively in a split-supply configuration if the input common-mode voltage (V_{ICR}), output swing (V_{OL} and V_{OH}), and supply voltage limits are not exceeded.

circuit layout precautions

Whenever extremely high circuit impedances are used, care must be exercised in layout, construction, board cleanliness, and supply filtering to avoid hum and noise pickup as well as excessive dc leakages.

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